Application/Control No. Reexamination 10/589,861 NYU. TAKAYUKI Notice of References Cited Art Unit Examiner Page 1 of 1 2617

Michael Mapa II S PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
*	Α	US-2003/0200455	10-2003	Wu, Chi-Kai	713/200		
*	В	US-7,382,756	06-2008	Barber et al.	370/338		
*	С	US-2004/0028001	02-2004	Billhartz, Thomas Jay	370/312		
	D	US-					
	Е	US-					
	F	US-					
	G	US-		-			
	Н	US-					
	_	US-					
	J	US-					
	К	US-					
	L	US-					
	М	US-					

FOREIGN PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	Q						
	R						
	s						
	Т						

NON-PATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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